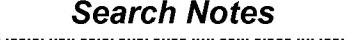


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/553,043	NIHEI ET AL.	
	Examiner	Art Unit	
	/Yonel Beaulieu/	3661	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Searched		4/1/2009	YB